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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/556,916	11/15/2005	Shigeyuki Akimoto	034398-004	1621
	7590 07/24/200 INGERSOLL & ROOI	EXAMINER		
POST OFFICE	BOX 1404	VANCHY JR, MICHAEL J		
ALEXANDRIA, VA 22313-1404			ART UNIT	PAPER NUMBER
			2624	
			NOTIFICATION DATE	DELIVERY MODE
			07/24/2008	ELECTRONIC

# Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Notice of the Office communication was sent electronically on above-indicated "Notification Date" to the following e-mail address(es):

ADIPFDD@bipc.com

		Application No.	Applicant(s)			
Office Action Commence		10/556,916	AKIMOTO ET AL.			
	Office Action Summary	Examiner	Art Unit			
		MICHAEL VANCHY JR	2624			
	The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply					
A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.  - Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.  - If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.  - Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).						
Status						
1)[🔀	Responsive to communication(s) filed on <u>07 Ap</u>	oril 2008				
·	This action is <b>FINAL</b> . 2b) This action is non-final.					
′=	· <del></del>					
٥/١	closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.					
	closed in accordance with the practice and i	x parte gadyle, 1000 0.D. 11, 10	0.0.210.			
Dispositi	on of Claims					
<ul> <li>4)  Claim(s) 1,4,5,8 and 9 is/are pending in the application.</li> <li>4a) Of the above claim(s) is/are withdrawn from consideration.</li> <li>5)  Claim(s) is/are allowed.</li> <li>6)  Claim(s) 1, 4, 5, 8, and 9 is/are rejected.</li> <li>7)  Claim(s) is/are objected to.</li> </ul>						
8) Claim(s) are subject to restriction and/or election requirement.						
Applicati	on Papers					
9)☐ The specification is objected to by the Examiner.						
10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.						
	Applicant may not request that any objection to the	drawing(s) be held in abeyance. See	9 37 CFR 1.85(a).			
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).						
11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.						
Priority u	ınder 35 U.S.C. § 119					
<ul> <li>12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).</li> <li>a) All b) Some * c) None of:</li> <li>1. Certified copies of the priority documents have been received.</li> <li>2. Certified copies of the priority documents have been received in Application No.</li> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> <li>* See the attached detailed Office action for a list of the certified copies not received.</li> </ul>						
2)  Notic 3) Inforr	t(s) e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (PTO-948) mation Disclosure Statement(s) (PTO/SB/08) r No(s)/Mail Date 04/07/2008.	4)  Interview Summary Paper No(s)/Mail Da 5)  Notice of Informal Pa 6)  Other:	ite			

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#### **DETAILED ACTION**

### Response to Arguments

- 1. Applicant's arguments with respect to claims 1, 4, 5, 8, and 9 have been considered but are moot in view of the new ground(s) of rejection.
- 2. Claims 2-3 and 6-7 have been canceled.

## Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 3. The factual inquiries set forth in *Graham* v. *John Deere Co.*, 383 U.S. 1, 148 USPQ 459 (1966), that are applied for establishing a background for determining obviousness under 35 U.S.C. 103(a) are summarized as follows:
  - 1. Determining the scope and contents of the prior art.
  - 2. Ascertaining the differences between the prior art and the claims at issue.
  - 3. Resolving the level of ordinary skill in the pertinent art.
  - 4. Considering objective evidence present in the application indicating obviousness or nonobviousness.
- 4. Claims 1, 4, 5, 8, and 9 are rejected under 35 U.S.C. 103(a) as being unpatentable over Tanaka et al., US 6,952,492 B2 and further in view of Toshiba et al., EP 0643293 A1.

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Regarding claim 1, Tanaka teaches an outer surface-inspecting method for inspecting an outer surface of an inspection area (Fig. 11, item "87") having repeated patterns through comparison (Fig. 11, items "61" col. 7, lines 30-40) with a predetermined master pattern, said method, comprising: dividing said inspection area having a rectangular shape into a plurality of matrix-like view areas; classifying a master pattern, according to respective different edge shapes of said inspection area (Col. 7, lines 30-40, The examiner takes into account that the master pattern is the strategic locations of the four corners and center, which forms a pattern.) involving four corner pattern portions each of which is applied to a respective corner portion of the inspection area and has an L-shaped edge shape (Fig. 11, col. 7, lines 30-40), and a central pattern portion without having an edge portion of the inspection area (Fig. 11, col. 7, lines 30-40); moving each of the side pattern portions relative to the inspection view areas along a peripheral portion of the inspection area having the repeated patterns between respective corner pattern portions, so as to be applied to respective matching inspection view areas of the peripheral portion; applying the single central pattern portion to matching of each of the inspection view areas at a central portion for the central portion surrounded by each of the peripheral portions; and inspecting the outer surface of the inspection area by comparing the standard pattern portions to the view areas corresponding to the classified standard pattern portions (col. 7, lines 30-40, The examiner clarifies that the pattern made by the four corners and center, are moved from one shot to another and thus each new shot is compared with the four corners and center pattern.).

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However, Tanaka does not explicitly state using <u>four side pattern portions each</u> of which is applied to a respective side of the inspection area and has a straight edge <u>portion</u>, thus giving nine standard pattern portions including the four corners and the center patterns. Edge detection is notoriously well known in the art, as is shown in EP 0643293 A1, which uses reference patterns as a master pattern to compare or match with an inspection pattern for edges and corners (Figs. 9A, 9B, 10A and 10B). Combining the edge detection capability of EP 0643293 A1, into Tanaka, results in nine standard pattern portions which can be used for alignment or defect detection. It would

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be obvious to one of ordinary skill in the art to modify Tanaka to include edge detection, to allow for a more precise matching ability between the master pattern and an inspection area.

**Regarding claim 4**, Tanaka teaches the outer surface-inspecting method set forth in claim 1, wherein an object to be inspected is a semiconductor chip (Abstract).

Regarding claim 5, see the rejection made to claim 1 for it address the limitations found in claim 5, excluding said matrix-like view areas being obtained by dividing said inspection area in <a href="https://horizontal.org/normal/">horizontal and vertical directions</a>. This can be found in Figure 11 of Tanaka. Since the inspection area is a rectangle the view is inherently divided into horizontal and vertical directions. Also, since the inspection area can be used over repetitive patterns, the entire inspection area is divided into horizontal and vertical directions.

**Regarding claim 8**, Tanaka teaches the master pattern forth in claim 5, wherein an object to be inspected is a semiconductor chip (Abstract).

**Regarding claim 9,** see the rejection made to claim 1 for it addresses all the limitations of the method of this apparatus.

#### Conclusion

1. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the

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shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later

than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to MICHAEL VANCHY JR whose telephone number is (571)270-1193. The examiner can normally be reached on Monday - Friday 8:30 am - 5:00 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Samir Ahmed can be reached on (571) 272-7413. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

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/Samir A. Ahmed/ Supervisory Patent Examiner, Art Unit 2624